Search Notes

	Application/Control No
	10/824,366
	Examiner
-	

B. Clayton McCraw

Applicant(s)/Patent under
Reexamination
LEE, CHANG LIM
Art Unit

3744

SEARCHED						
Class	Subclass	Date	Examiner			
138	110	4/26/2006	всм			
138	110	11/10/2006	всм			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOT (INCLUDING SEARCH) .
	DATE	EXMR
Consulted with Primary Examiner, William Doerrler	4/26/2006	всм
Consulted with Primary Examiner, James Hook	4/26/2006	всм
Conducted Inventor Name Search	4/26/2006	всм
EAST Search Notes Attached	4/26/2006	всм
Consulted with Primary Examiner, William Doerrler	11/1/2006	всм